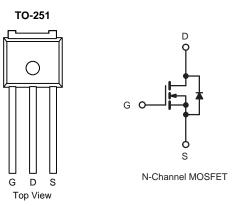


# HY1403U-VB Datasheet N-Channel 30-V (D-S) MOSFET

PRODUC	PRODUCT SUMMARY			
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $m\Omega$ )	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)	
30	7 at V <sub>GS</sub> = 10 V	50	19 nC	
30	9 at V <sub>GS</sub> = 4.5 V	45	19110	



#### **FEATURES**

- · Halogen-free
- Trench Gen III Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested

#### **APPLICATIONS**

- DC/DC Conversion
  - System Power

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$	I <sub>D</sub>	50 45 14 <sup>b, c</sup> 10 <sup>b, c</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	150		
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	25		
Avalanche Energy	L=0.1 IIII	E <sub>AS</sub>	40	mJ	
Continuous Source-Drain Diode Current $T_C = 25 \text{ °C}$ $T_A = 25 \text{ °C}$		I <sub>S</sub>	15 2.9 <sup>b, c</sup>	Α	
$ \begin{array}{c} T_{C} = 25 \ ^{\circ}C \\ \hline T_{C} = 70 \ ^{\circ}C \\ \hline T_{A} = 25 \ ^{\circ}C \\ \hline T_{A} = 70 \ ^{\circ}C \\ \hline \end{array} $		P <sub>D</sub>	28 18 3.5 <sup>b, c</sup> 2.2 <sup>b, c</sup>	w	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RAT	ERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient	t ≤ 10 s	R <sub>thJA</sub>	29	36	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	3.6	4.5	J 5/ VV	

#### Notes:

- a. Based on T<sub>C</sub> = 25 °C.
  b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				•		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		33		m)//°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	1.2		3.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zara Cata Valta na Duain Comment	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			5	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	15			Α
Danie Common Co Olote Desistence		$V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		7		0
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_{D} = 7 \text{ A}$		9		mΩ
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A		24		S
Dynamic <sup>b</sup>				•		
Input Capacitance	C <sub>iss</sub>			1700		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		200		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			150		1
Tatal Oata Obanna	0	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		33		
Total Gate Charge	Q <sub>g</sub>		18	18		nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		7.3		
Gate-Drain Charge	Q <sub>gd</sub>			6.2		
Gate Resistance	$R_g$	f = 1 MHz	0.2	0.8	1.6	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			15	30	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.5 $\Omega$		12	24	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ 10 A, $V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$		13	26	
Fall Time	t <sub>f</sub>			10	20	
Turn-On Delay Time	t <sub>d(on)</sub>			9	18	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.5 $\Omega$		9	18	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 10$ A, $V_{GEN}=10$ V, $R_g=1$ $\Omega$		14	28	
Fall Time	t <sub>f</sub>			8	16	1
<b>Drain-Source Body Diode Characteristi</b>	cs			•		
Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$			16	Α
Pulse Diode Forward Current	I <sub>SM</sub>				32	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 3 A, V <sub>GS</sub> = 0 V		0.78	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			17	34	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		9.5	19	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$i_F = 10 \text{ A}$ , $u_1/u_1 = 100 \text{ A/}\mu s$ , $i_J = 25 \text{ C}$		10		
Reverse Recovery Rise Time	t <sub>b</sub>			7		ns

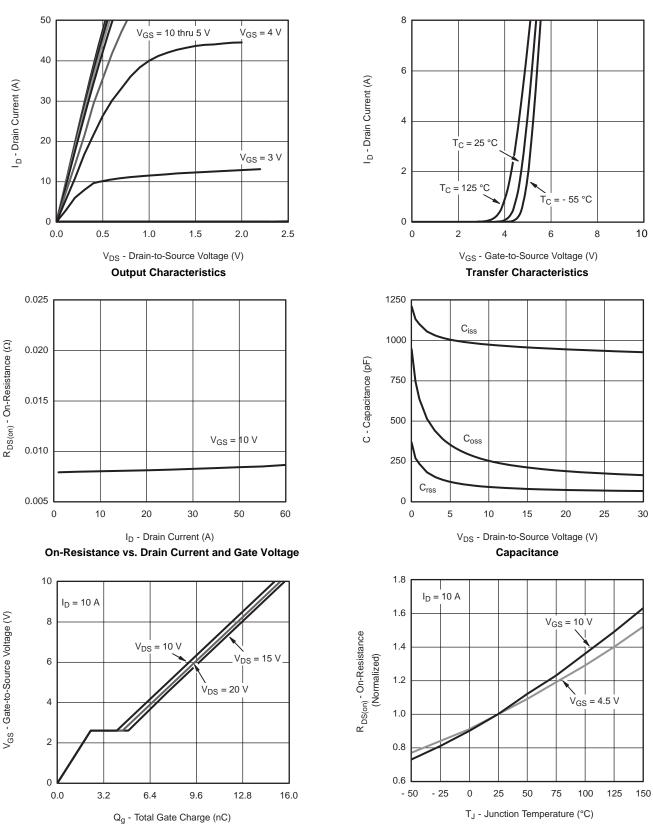
#### Notes:

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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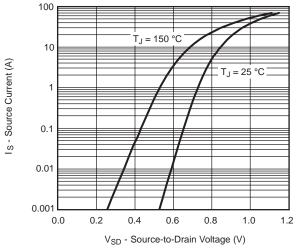


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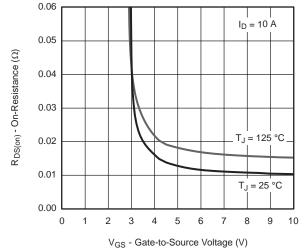
**Gate Charge** 

On-Resistance vs. Junction Temperature





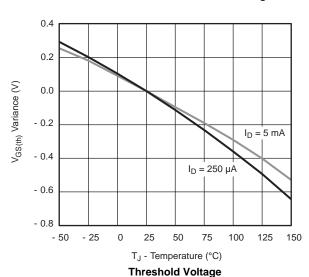
Source-Drain Diode Forward Voltage

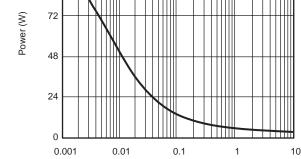


On-Resistance vs. Gate-to-Source Voltage

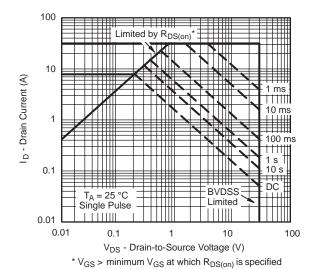
120

96



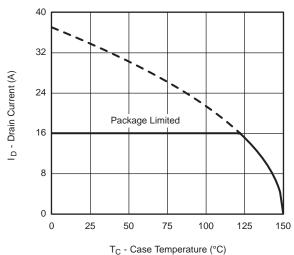


Time (s) Single Pulse Power (Junction-to-Ambient)



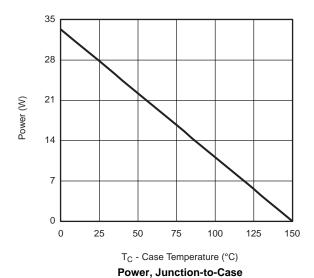
Safe Operating Area, Junction-to-Ambient

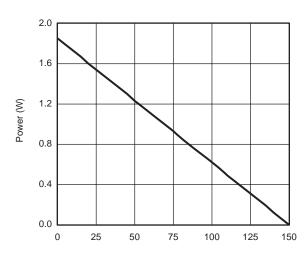




Current Dereting\*

#### **Current Derating\***



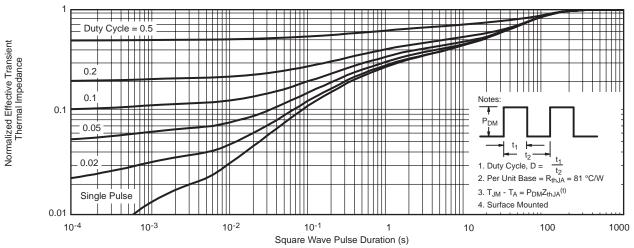


T<sub>A</sub> - Case Temperature (°C)

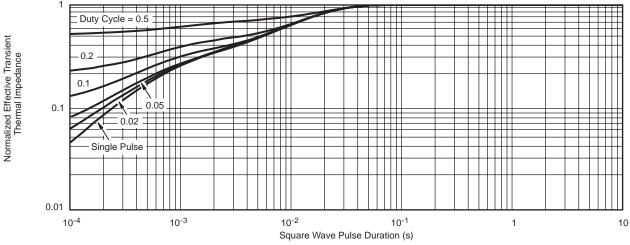
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





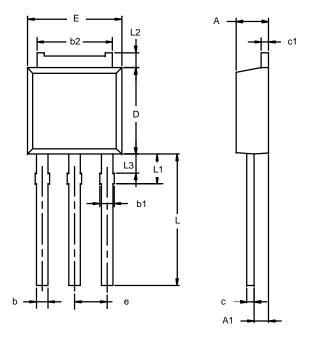
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



### TO-251AA (DPAK)



Note: Dimension L3 is for reference only.

	MILLIM	IETERS	INC	HES	
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
<b>A</b> 1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
с1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28	BSC	0.090	0.090 BSC	
L	3.89	9.53	0.153	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	
ECN: S-0 DWG: 53	3946—Rev. E 346	, 09-Jul-01		•	



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